

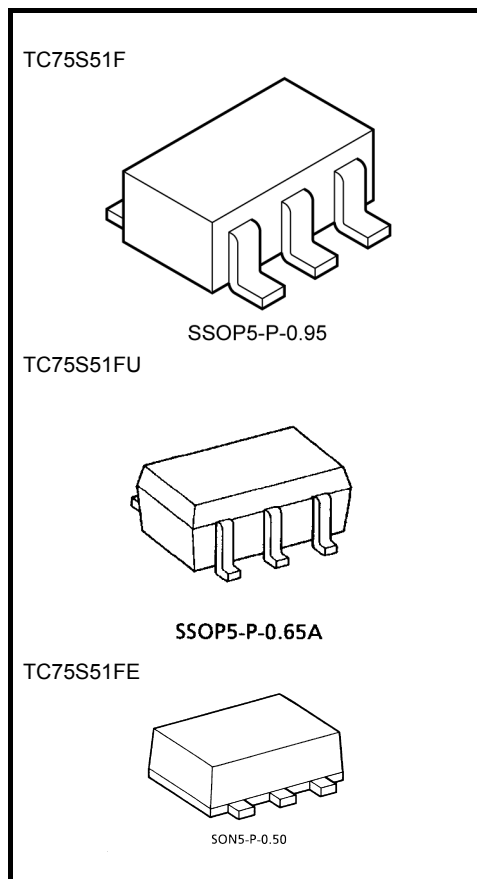
TC75S51F, TC75S51FU, TC75S51FE

Single Operational Amplifier

The TC75S51F/TC75S51FU/TC75S51FE is a CMOS single-operation amplifier which incorporates a phase compensation circuit. It is designed for use with a low-voltage, low-current power supply; this differentiates this device from conventional general-purpose bipolar op-amps.

Features

- Low-voltage operation : $V_{DD} = \pm 0.75 \sim \pm 3.5$ V or 1.5~7 V
- Low-current power supply : $I_{DD} (V_{DD} = 3$ V) = 60 μ A (typ.)
- Built-in phase-compensated op-amp, obviating the need for any external device
- Ultra-compact package



Weight

SSOP5-P-0.95 : 0.014 g (typ.)

SSOP5-P-0.65A : 0.006 g (typ.)

SON5-P-0.50 : 0.003 g (typ.)

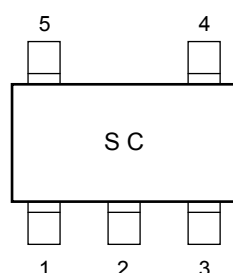
Absolute Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit
Supply voltage		V_{DD}, V_{SS}	7	V
Differential input voltage		DV_{IN}	± 7	V
Input voltage		V_{IN}	$V_{DD} \sim V_{SS}$	V
Power dissipation	TC75S51F/FU	P_D	200	mW
	TC75S51FE		100	
Operating temperature		T_{opr}	-40~85	°C
Storage temperature		T_{stg}	-55~125	°C

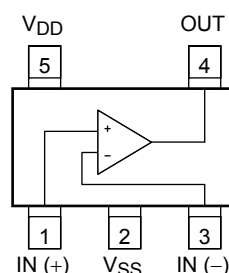
Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Marking (top view)



Pin Connection (top view)



Electrical Characteristics

DC Characteristics ($V_{DD} = 3.0\text{ V}$, $V_{SS} = \text{GND}$, $T_a = 25^\circ\text{C}$)

Characteristics	Symbol	Test Circuit	Test Condition	Min	Typ.	Max	Unit
Input offset voltage	V_{IO}	1	$R_S = 1\text{ k}\Omega$, $R_F = 100\text{ k}\Omega$	—	2	10	mV
Input offset current	I_{IO}	—	—	—	1	—	pA
Input bias current	I_I	—	—	—	1	—	pA
Common mode input voltage	CMV_{IN}	2	$R_S = 1\text{ k}\Omega$, $R_F = 100\text{ k}\Omega$	0	—	2.5	V
Voltage gain (open loop)	G_V	—	—	60	70	—	dB
Maximum output voltage	V_{OH}	3	$R_L \geq 100\text{ k}\Omega$	2.9	—	—	V
	V_{OL}	4	$R_L \geq 100\text{ k}\Omega$	—	—	0.1	
Common mode input signal rejection ratio	CMRR	2	$V_{IN} = 0.0\sim 2.5\text{ V}$	55	65	—	dB
Supply voltage rejection ratio	SVRR	1	$V_{DD} = 1.5\sim 7.0\text{ V}$	60	70	—	dB
Supply current	I_{DD}	5	—	—	60	200	μA

DC Characteristics ($V_{DD} = 1.5\text{ V}$, $V_{SS} = \text{GND}$, $T_a = 25^\circ\text{C}$)

Characteristics	Symbol	Test Circuit	Test Condition	Min	Typ.	Max	Unit
Input offset voltage	V_{IO}	1	$R_S = 10\text{ k}\Omega$, $R_F = 100\text{ k}\Omega$	—	2	10	mV
Input offset current	I_{IO}	—	—	—	1	—	pA
Input bias current	I_I	—	—	—	1	—	pA
Common mode input voltage	CMV_{IN}	2	$R_S = 10\text{ k}\Omega$, $R_F = 100\text{ k}\Omega$	0	—	1.0	V
Voltage gain (open loop)	G_V	—	—	60	70	—	dB
Maximum output voltage	V_{OH}	3	$R_L \geq 100\text{ k}\Omega$	1.4	—	—	V
	V_{OL}	4	$R_L \geq 100\text{ k}\Omega$	—	—	0.1	
Supply current	I_{DD}	5	—	—	50	150	μA

Note: For this device, please use a source current of no more than 70 μA .

AC Characteristics ($V_{DD} = 3.0\text{ V}$, $V_{SS} = \text{GND}$, $T_a = 25^\circ\text{C}$)

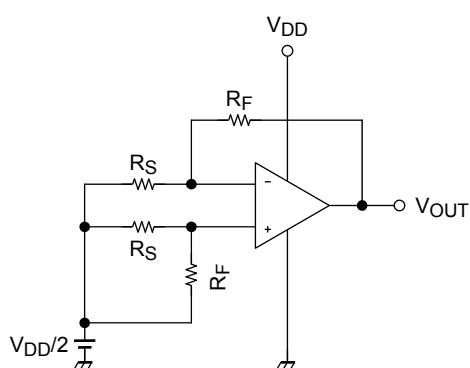
Characteristics	Symbol	Test Circuit	Test Condition	Min	Typ.	Max	Unit
Slew rate	SR	—	$A_V = 0\text{ dB}$	—	0.5	—	$\text{V}/\mu\text{s}$
Unity gain cross frequency	f_T	—	$A_V = 40\text{ dB}$	—	0.6	—	MHz

AC Characteristics ($V_{DD} = 1.5\text{ V}$, $V_{SS} = \text{GND}$, $T_a = 25^\circ\text{C}$)

Characteristics	Symbol	Test Circuit	Test Condition	Min	Typ.	Max	Unit
Slew rate	SR	—	$A_V = 0\text{ dB}$	—	0.3	—	$\text{V}/\mu\text{s}$
Unity gain cross frequency	f_T	—	$A_V = 40\text{ dB}$	—	0.5	—	MHz

Test Circuit

1. SVRR, V_{IO}



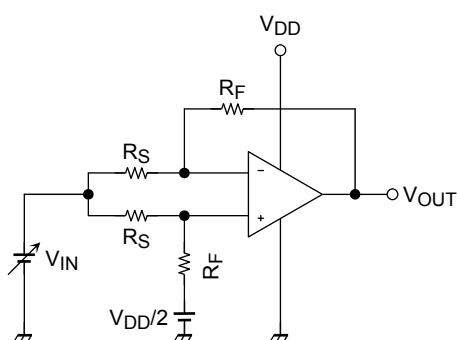
- SVRR
For each of the two V_{DD} values, measure the V_{OUT} value, as indicated below, and calculate the value of SVRR using the equation shown.
When $V_{DD} = 1.5\text{ V}$, $V_{DD} = V_{DD1}$ and $V_{OUT} = V_{OUT1}$
When $V_{DD} = 7.0\text{ V}$, $V_{DD} = V_{DD2}$ and $V_{OUT} = V_{OUT2}$

$$\text{SVRR} = 20 \log \left(\left| \frac{V_{OUT1} - V_{OUT2}}{V_{DD1} - V_{DD2}} \right| \times \frac{R_S}{R_F + R_S} \right)$$

- V_{IO}
Measure the value of V_{OUT} and calculate the value of V_{IO} using the following equation.

$$V_{IO} = \left(V_{OUT} - \frac{V_{DD}}{2} \right) \times \frac{R_S}{R_F + R_S}$$

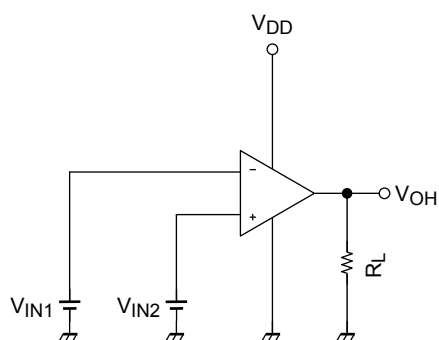
2. CMRR, CMV_{IN}



- CMRR
Measure the V_{OUT} value, as indicated below, and calculate the value of the CMRR using the equation shown.
When $V_{IN} = 0.0\text{ V}$, $V_{IN} = V_{IN1}$ and $V_{OUT} = V_{OUT1}$
When $V_{IN} = 2.5\text{ V}$, $V_{IN} = V_{IN2}$ and $V_{OUT} = V_{OUT2}$

$$\text{CMRR} = 20 \log \left(\left| \frac{V_{OUT1} - V_{OUT2}}{V_{IN1} - V_{IN2}} \right| \times \frac{R_S}{R_F + R_S} \right)$$

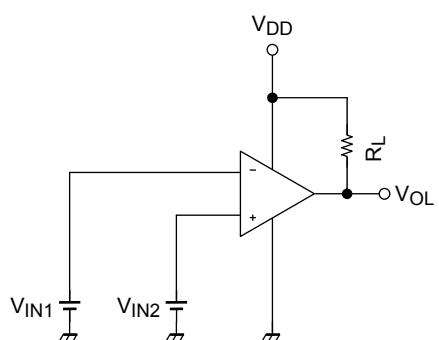
- CMV_{IN}
Input range within which the CMRR specification guarantees V_{OUT} value (as varied by the V_{IN} value).

3. V_{OH}


- V_{OH}

$$V_{IN1} = \frac{V_{DD}}{2} - 0.05 \text{ V}$$

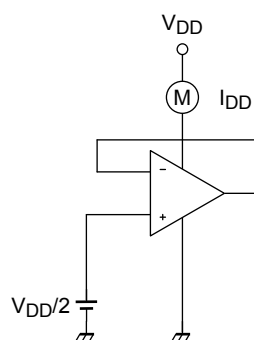
$$V_{IN2} = \frac{V_{DD}}{2} + 0.05 \text{ V}$$

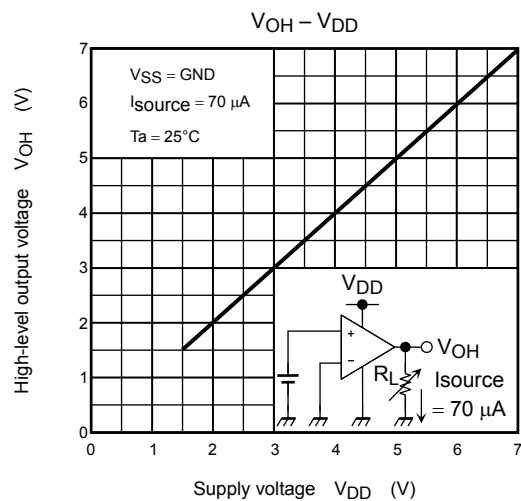
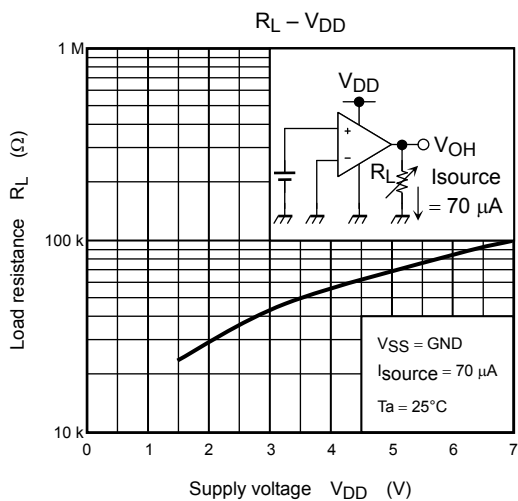
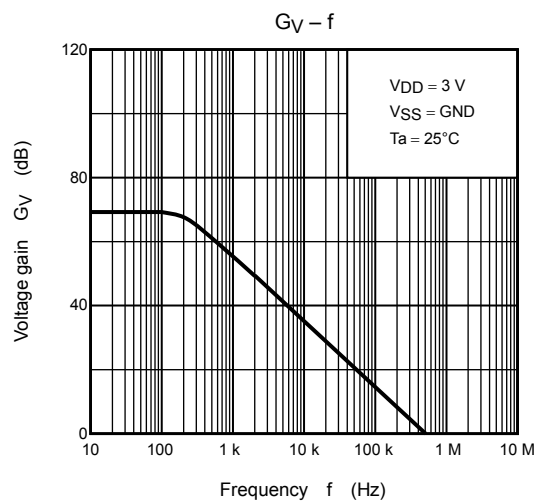
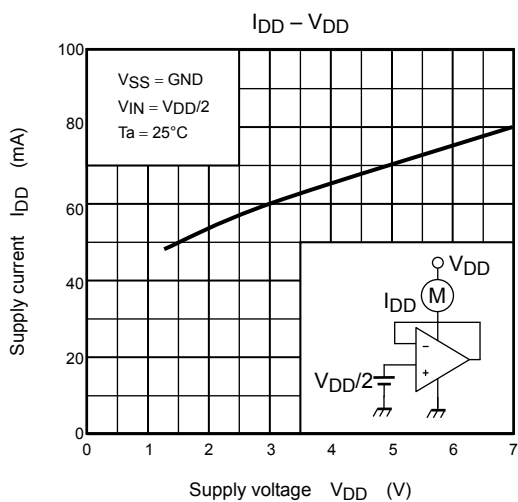
4. V_{OL}


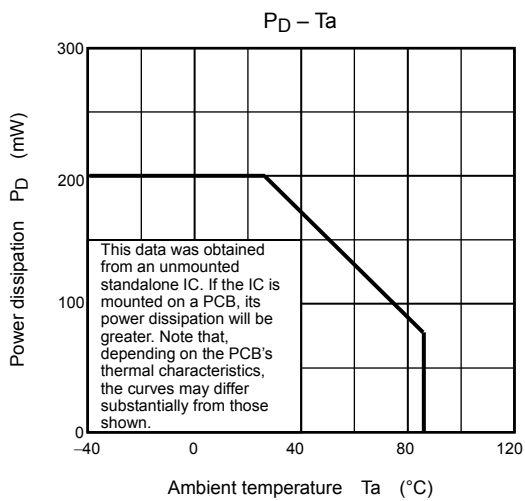
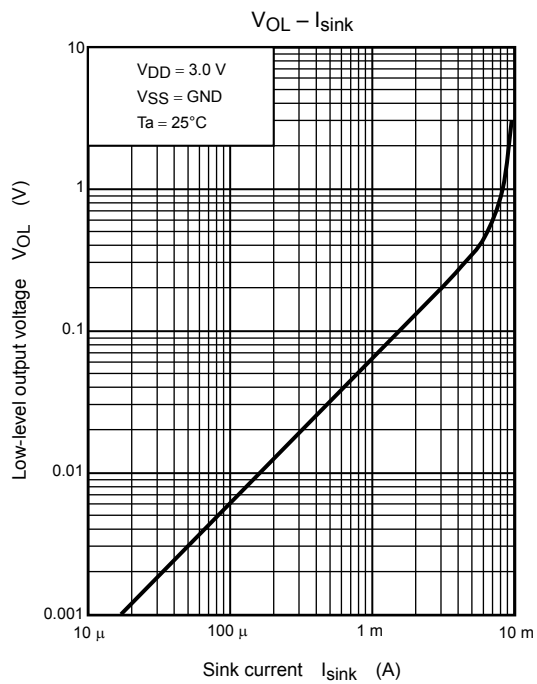
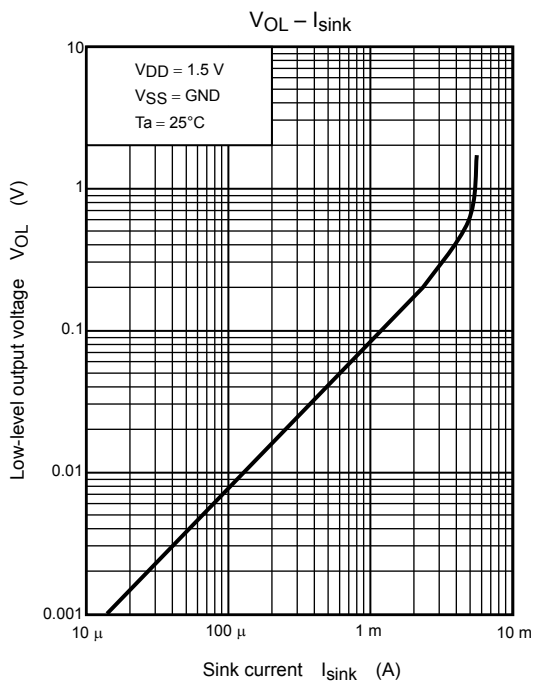
- V_{OL}

$$V_{IN1} = \frac{V_{DD}}{2} + 0.05 \text{ V}$$

$$V_{IN2} = \frac{V_{DD}}{2} - 0.05 \text{ V}$$

5. I_{DD}


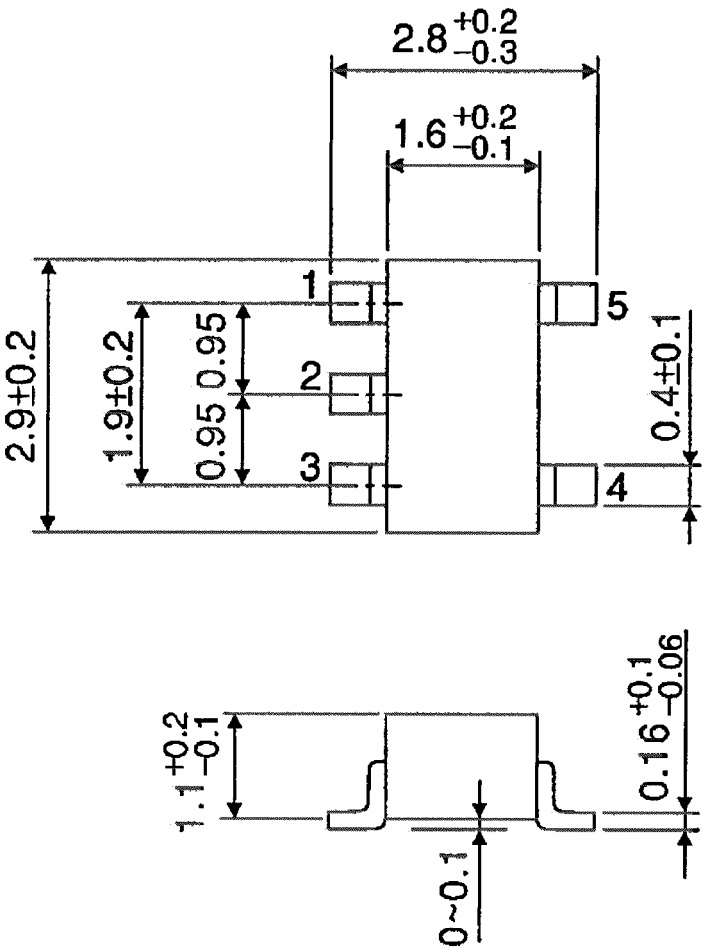




Package Dimensions

SSOP5-P-0.95

Unit : mm

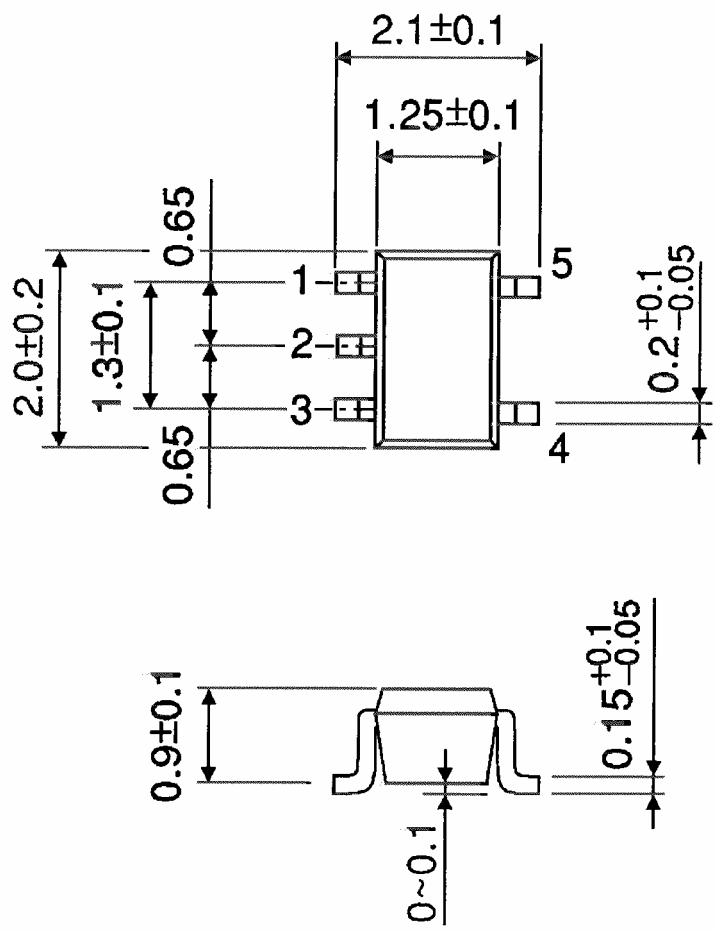


Weight: 0.014 g (typ.)

Package Dimensions

SSOP5-P-0.65A

Unit : mm

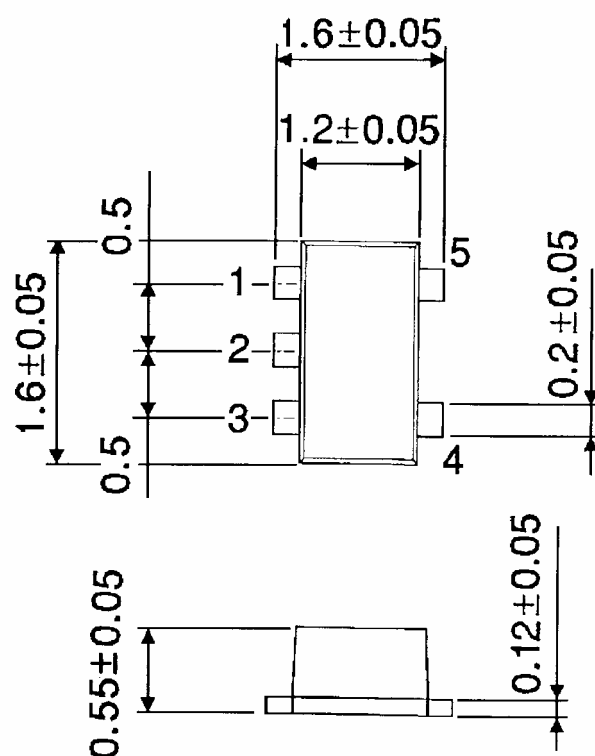


Weight: 0.006 g (typ.)

Package Dimensions

SON5-P-0.50

Unit : mm



Weight: 0.003 g (typ.)

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20070701-EN GENERAL

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